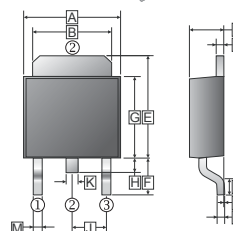
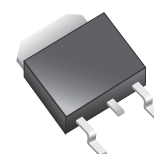


RoHS Compliant Product
A suffix of "-C" specifies halogen free

DESCRIPTION

These miniature surface mount MOSFETs utilize a high cell density trench process to provide Low $R_{DS(on)}$ and to ensure minimal power loss and heat dissipation. Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

TO-252(D-Pack)

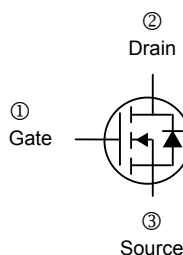


FEATURES

- Low $R_{DS(on)}$ provides higher efficiency and extends battery life.
- Low thermal impedance copper leadframe DPAK saves board space.
- Fast switching speed.
- High performance trench technology.

PRODUCT SUMMARY

PRODUCT SUMMARY		
$V_{DS}(V)$	$R_{DS(on)}$ m(Ω)	$I_D(A)$
150	255@ $V_{GS}=10V$	12
	290@ $V_{GS}=5.5V$	11



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	6.4	6.8	J	2.30	REF.
B	5.20	5.50	K	0.70	0.90
C	2.20	2.40	M	0.50	1.1
D	0.45	0.58	N	0.9	1.6
E	6.8	7.3	O	0	0.15
F	2.40	3.0	P	0.43	0.58
G	5.40	6.2			
H	0.8	1.20			

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$ unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Drain-Source Voltage	V_{DS}	150	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ^a	$I_D @ T_C=25^\circ C$	12	A
Pulsed Drain Current ^b	I_{DM}	36	A
Continuous Source Current (Diode Conduction) ^a	I_S	30	A
Total Power Dissipation ^a	$P_D @ T_C=25^\circ C$	50	W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 ~ 175	$^\circ C$

THERMAL RESISTANCE RATINGS

Maximum Thermal Resistance Junction-Ambient ^a	$R_{\theta JA}$	50	$^\circ C / W$
Maximum Thermal Resistance Junction-Case	$R_{\theta JC}$	3.0	$^\circ C / W$

Notes :

- Surface Mounted on 1" x 1" FR4 Board.
- Pulse width limited by maximum junction temperature.

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise specified)

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Static						
Gate-Threshold Voltage	$V_{GS(th)}$	1.0	-	-	V	$V_{DS} = V_{GS}$, $I_D = 250 \mu\text{A}$
Gate-Body Leakage	I_{GSS}	-	-	± 100	nA	$V_{DS} = 0\text{V}$, $V_{GS} = 20\text{V}$
Zero Gate Voltage Drain Current	I_{DSS}	-	-	1	μA	$V_{DS} = 120\text{V}$, $V_{GS} = 0\text{V}$
		-	-	25		$V_{DS} = 120\text{V}$, $V_{GS} = 0\text{V}$, $T_J = 55^\circ\text{C}$
On-State Drain Current ^a	$I_{D(on)}$	34	-	-	A	$V_{DS} = 5\text{V}$, $V_{GS} = 10\text{V}$
Drain-Source On-Resistance ^a	$R_{DS(ON)}$	-	-	255	m Ω	$V_{GS} = 10\text{V}$, $I_D = 9.2\text{A}$
		-	-	290		$V_{GS} = 5.5\text{V}$, $I_D = 6.1\text{A}$
Forward Transconductance ^a	g_{fs}	-	4.4	-	S	$V_{DS} = 40\text{V}$, $I_D = 5.5\text{A}$
Diode Forward Voltage	V_{SD}	-	1.1	-	V	$I_S = 9\text{A}$, $V_{GS} = 0\text{V}$
Dynamic ^b						
Total Gate Charge	Q_g	-	19	-	nC	$V_{DS} = 25\text{V}$ $V_{GS} = 10\text{V}$ $I_D = 9\text{A}$
Gate-Source Charge	Q_{gs}	-	3	-		
Gate-Drain Charge	Q_{gd}	-	9.5	-		
Turn-on Delay Time	$T_{d(on)}$	-	25	-	nS	$V_{DD} = 100\text{V}$ $I_D = 9\text{A}$ $V_{GEN} = 10\text{V}$ $R_L = 25\Omega$
Rise Time	T_r	-	60	-		
Turn-off Delay Time	$T_{d(off)}$	-	65	-		
Fall Time	T_f	-	45	-		

Notes

- a. Pulse test : Pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.
b. Guaranteed by design, not subject to production testing.